Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/903,521	NAKAMURA, SATOSHI	
Examiner	Art Unit	

Nhan T. Tran

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SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	search - see ory printout	1/17/2006	NT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) text search - see search history printout	11/28/2005	NT		
348/251-256 (text search - see search history printout)	1/17/2006	NT		
358/448, 461, 515-523 (text search - see search history printout)	1/17/2006	NT		
382/167, 266-275 (text search - see search history printout)	1/17/2006	NT		
LIN YE	1/17/2006	NT		
TUAN HO	1/17/2006	NT		